

Applicant(s)/Patent Reexamination	under
CLARK, EDWARD	ALAN
Art Unit	;
	Reexamination CLARK, EDWARD

Joseph T. Phan

2614

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East Search	12/21/2007	JTP	
(IVR or "voice response") and SIP and XML and HTTP	12/21/2007	JTP	